



TEST REPORT

KCTL Inc. 65, Sinwon-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do, 16677, Korea TEL: 82-31-285-0894 FAX: 82-505-299-8311 www.kctl.co.kr	Report No.: KR20-SRF0011-A Page (1) of (11)			
1. Client ◦ Name : Samsung Electronics Co., Ltd. ◦ Address : 129, Samsung-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do, 16677, Rep. of Korea ◦ Date of Receipt : 2019-12-09 2. Use of Report : Class II Permissive change 3. Name of Product and Model : Sound bar / HW-T420 4. Manufacturer and Country of Origin : Samsung Electronics Co., Ltd. / China 5. FCC ID : A3LHWT450 6. IC Certificate No. : 649E-HWT450 7. Date of Test : 2019-12-20 to 2020-01-06 8. Test Standards : FCC Part 15 Subpart C, 15.247 RSS-247 Issue 2 February 2017 RSS-Gen Issue 5 March 2019 9. Test Results : Refer to the test result in the test report				
Affirmation	<table border="1" style="width: 100%; border-collapse: collapse;"> <tr> <td style="width: 50%; padding: 5px;"> Tested by Name : Heesu Ahn (Signature) </td> <td style="width: 50%; padding: 5px;"> Technical Manager Name : Jaehyong Lee (Signature) </td> </tr> </table>		Tested by Name : Heesu Ahn (Signature)	Technical Manager Name : Jaehyong Lee (Signature)
Tested by Name : Heesu Ahn (Signature)	Technical Manager Name : Jaehyong Lee (Signature)			
2020-01-29 KCTL Inc. As a test result of the sample which was submitted from the client, this report does not guarantee the whole product quality. This test report should not be used and copied without a written agreement by KCTL Inc.				

Report revision history

Date	Revision	Page No
2020-01-21	Initial report	-
2020-01-29	Revised a typo	10

This report shall not be reproduced except in full, without the written approval of KCTL Inc. This document may be altered or revised by KCTL Inc. personnel only, and shall be noted in the revision section of the document. Any alteration of this document not carried out by KCTL Inc. will constitute fraud and shall nullify the document. This test report is a general report that does not use the KOLAS accreditation mark and is not related to KOLAS accreditation.

KCTL

CONTENTS

1. General information4

2. Device information4

 2.1. Accessory information4

 2.2. Frequency/channel operations.....5

3. Measurement uncertainty5

4. RF Exposure6

 4.1. Test results.....9

5. Measurement Equipment..... 11



1. General information

Client : Samsung Electronics Co., Ltd.
 Address : 129, Samsung-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do, 16677, Rep. of Korea
 Manufacturer : Samsung Electronics Co., Ltd.
 Address : 129, Samsung-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do, 16677, Rep. of Korea
 Factory : TCLTechnoly Electronics (Huizhou) Co., Ltd. Zhongkai The Third Factory
 Address : NO.88, North Of Luen Fat Road, Tongqiao Industrial Base, Zhongkai High-techDevelopment Zone, Huizhou City, Guangdong Province, P.R.China
 Laboratory : KCTL Inc.
 Address : 65, Sinwon-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do, 16677, Korea
 Accreditations : FCC Site Designation No: KR0040, FCC Site Registration No: 687132
 VCCI Registration No. : R-20080, G-20078, C-20059, T-20056
 Industry Canada Registration No. : 8035A
 KOLAS No.: KT231

2. Device information

Equipment under test : Sound bar
 Model : HW-T420
 Frequency range : 2 402 MHz ~ 2 480 MHz
 Modulation technique : GFSK, $\pi/4$ DQPSK, 8DPSK
 Number of channels : 79 ch
 Power source : AC 120 V
 Antenna specification : PCB Antenna
 Antenna gain : 1.48 dBi
 Software version : 13
 Hardware version : D
 Test device serial No. : N/A
 Operation temperature : -20 °C ~ 70 °C

2.1. Accessory information

Equipment	Manufacturer	Model	Serial No.	Power source
Woofer	Samsung Electronics Co.,Ltd.	PS-T4SWT	-	AC 120 V
Remote Controller	Samsung Electronics Co.,Ltd.	AH59-02767A	-	DC 1.5 V

2.2. Frequency/channel operations

This device contains the following capabilities:

Bluetooth(BDR/EDR)

Ch.	Frequency (MHz)
00	2 402
.	.
19	2 441
.	.
39	2 480

Table 2.2.1. Bluetooth(BDR/EDR) mode

3. Measurement uncertainty

The measurement uncertainties shown below were calculated in accordance with the requirements of ANSI C63.10-2013.

All measurement uncertainty values are shown with a coverage factor of $k=2$ to indicated a 95 % level of confidence. The measurement data shown herein meets or exceeds the U_{CISPR} measurement uncertainty values specified in CISPR 16-4-2 and thus, can be compared directly to specified limits to determine compliance.

Parameter	Expanded uncertainty ($\pm$)
Conducted RF power	1.76 dB

4. RF Exposure

FCC

Regulation

This document is prepared to show compliance with the RF Exposure requirements as required in §1.1310 of the FCC rules and Regulations.

The limit for Maximum Permissible Exposure (MPE), specified in FCC §1.1310, is listed in Table 1-1. According to FCC §1.1310: the criteria listed in the following table shall be used to evaluate the environmental impact of human exposure to radio-frequency (RF) radiation as specified in §1.1307(b).

Table 1 – Limits for Maximum Permissible Exposure (MPE)

Frequency Range (MHz)	Electric Field Strength [V/m]	Magnetic Field Strength [A/m]	Power Density [mW/cm ²]	Averaging Time [minute]
(A) Limits for Occupational / Controlled Exposure				
0.3 ~ 3.0	614	1.63	*100	6
3.0 ~ 30	1842/f	4.89/f	*900/f ²	6
30 ~ 300	61.4	0.163	1.0	6
300 ~ 1 500	/	/	f/300	6
1 500 ~ 15 000	/	/	5	6
(B) Limits for General Population / Uncontrolled Exposure				
0.3 ~ 1.34	614	1.63	*100	30
1.34 ~ 30	824/f	2.19/f	*180/f ²	30
30 ~ 300	27.5	0.073	0.2	30
300 ~ 1 500	/	/	f/1 500	30
1 500 ~ 15 000	/	/	1.0	30

f=frequency in MHz, * = plane-wave equivalent power density

Per the guidance of KDB 680106, the E-field and H-field limits shown in the table above are extended down to 100 kHz

IC

RF Field Strength Limits for Devices Used by the General Public (Uncontrolled Environment)

According to RSS-102 Issue 5, Paragraph "4. Exposure Limits", Industry of Canada has adopted the RF field strength limits established in Health Canada's RF exposure guideline, Safety code 6:

Frequency Range (MHz)	Electric Field (V/m rms)	Magnetic Field (A/m rms)	Power Density (W/m ²)	Reference Period (minutes)
0.003-10 ²¹	83	90	-	Instantaneous*
0.1-10	-	0.73/ f	-	6**
1.1-10	87/ $f^{0.5}$	-	-	6**
10-20	27.46	0.0728	2	6
20-48	58.07/ $f^{0.25}$	0.1540/ $f^{0.25}$	8.944/ $f^{0.5}$	6
48-300	22.06	0.05852	1.291	6
<u>300-6000</u>	<u>3.142 $f^{0.3417}$</u>	<u>0.008335 $f^{0.3417}$</u>	<u>0.02619 $f^{0.6834}$</u>	<u>6</u>
6000-15000	61.4	0.163	10	6
15000-150000	61.4	0.163	10	616000/ $f^{1.2}$
150000-300000	0.158 $f^{0.5}$	4.21 x 10 ⁻⁴ $f^{0.5}$	6.67 x 10 ⁻⁵ f	616000/ $f^{1.2}$
Note: f is frequency in MHz. *Based on nerve stimulation (NS). ** Based on specific absorption rate (SAR).				

Exemption Limits for Routine Evaluation – RF Exposure Evaluation

According to RSS-102 Issue 5 section 2.5.2, RF exposure evaluation is required if the separation distance between the user and/or bystander and the device's radiating element is greater than 20 cm, except when the device operates as follows:

- Below 20 MHz and the source-based, time-averaged maximum e.i.r.p. of the device is equal to or less than 1W (adjusted for tune-up tolerance);
- At or above 20 MHz and below 48 MHz and the source-based, time-averaged maximum e.i.r.p. of the device is equal to or less than $4.49/f^{0.5}$ W (adjusted for tune-up tolerance), where f is in MHz;
- At or above 48 MHz and below 300 MHz and the source-based, time-averaged maximum e.i.r.p. of the device is equal to or less than 0.6 W (adjusted for tune-up tolerance);
- At or above 300 MHz and below 6 GHz and the source-based, time-averaged maximum e.i.r.p. of the device is equal to or less than $1.31 \times 10^{-2} f^{0.6834}$ W (adjusted for tune-up tolerance), where f is in MHz;
- At or above 6 GHz and the source-based, time-averaged maximum e.i.r.p. of the device is equal to or less than 5 W (adjusted for tune-up tolerance.)

In these cases, the information contained in the RF exposure technical brief may be limited to information that demonstrates how the e.i.r.p. was derived.

KCTL

4.1. Test results

FCC

MPE (Maximum Permissible Exposure) Prediction

Predication of MPE limit at a given distance: Equation from page 18 of OET Bulletin 65, Edition 97-01

$$S = PG/4\pi R^2 \quad (\Rightarrow R = \sqrt{PG/4\pi S})$$

S = power density [mW/cm^2]

P = Power input to antenna [mW]

G = Power gain of the antenna in the direction of interest relative to an isotropic radiator

R = distance to the center of radiation of the antenna [cm]

IC

RF Exposure evaluation

At or above 300 MHz and below 6 GHz and the source-based, time-averaged maximum e.i.r.p. of the device is equal to or less than $1.31 \times 10^{-2} f^{0.6834} \text{ W}$ (adjusted for tune-up tolerance), where f is in MHz;

RF Exposure Compliance Issue

The information should be included in the user's manual:

This appliance and its antenna must not be co-located or operation is conjunction with any other antenna or transmitter. A minimum separation distance of 20 cm must be maintained between the antenna and the person for this appliance to satisfy the RF exposure requirements.

Calculation Result of RF exposure

(FCC)

Mode	Frequency [MHz]	Max Tune-up Power [dBm]	Max Tune-up Power [mW]	Ant Gain [dBi]	Ant Gain [mW]	Power density at 20 cm [mW/cm ²]	Limit [mW/cm ²]
GFSK	2 441	7.00	5.01	1.48	1.41	0.001 40	1.00

Note.

- The power density P_d (5th column) at a distance of 20 cm calculated from the friis transmission Formula is far below the limit of 1 mW/cm².

(IC)

Mode	Frequency [MHz]	Max Tune-up Power [dBm]	Ant Gain [dBi]	E.I.R.P		Limit [mW]	Ratio
				[dBm]	[mW]		
GFSK	2 441	7.00	1.48	8.48	7.05	2 706.05	0.002 6



5. Measurement Equipment

Equipment Name	Manufacturer	Model No.	Serial No.	Next Cal. Date
Wideband Power Sensor	R&S	NRP-Z81	102398	20.01.25
ATTENUATOR	R&S	DNF Dämpfungsglied 10 dB in N-50 Ohm	31212	20.05.13

End of test report

KCTL